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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/766,336	01/28/2004	Shyh-Mei F. Ho	SVL920030102US1	3271
45112 7590 08/29/2908 Kunzler & McKenzie 8 EAST BROADWAY			EXAMINER	
			ALVESTEFFER, STEPHEN D	
SUITE 600 SALT LAKE	CITY, UT 84111		ART UNIT	PAPER NUMBER
	,		2175	
			MAIL DATE	DELIVERY MODE
			08/29/2008	PAPER

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

Interview Summary

 Application No.
 Applicant(s)

 10/766,336
 HO ET AL.

 Examiner
 Art Unit

 Stephen Alvesteffer
 2175

All participants (applicant, applicant's representative, PTO personnel):

(1) Stephen Alvesteffer, examiner of record.	(3)Mr. David J. McKenzie, Reg.#46,919, for applicant.
(2) William Bashore, supervisory patent examiner.	(4)Mr. Alec J. McGinn, for applicant.
Date of Interview: 27 August 2008.	
Type: a)⊠ Telephonic b)☐ Video Conference c)☐ Personal [copy given to: 1)☐ applicant	2) applicant's representative]
Exhibit shown or demonstration conducted: d) Yes If Yes, brief description:	e)⊠ No.
Claim(s) discussed: 29.	
Identification of prior art discussed: Bach (5,781,739), Ba	ach (6,141,660), and Francis (6,665,861).
Agreement with respect to the claims f) $\hfill \square$ was reached.	g)⊠ was not reached. h) N/A.
claims might be amended to distinguish over the prior are (A fuller description, if necessary, and a copy of the ame allowable, if available, must be attached. Also, where no allowable is available, a summary thereof must be attach THE FORMAL WRITTEN REPLY TO THE LAST OFFICE INTERVIEW. (See MPEP Section 713.04). If a reply to to GIVEN A NON-EXTENDABLE PERIOD OF THE LONGE	tives discussed proposed claim amendments and how the d. I. I. I. I. I. I. I. I. I.
	/William L. Bashore/ Supervisory Patent Examiner, Art Unit 2175